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| Notice of References Cited | Application/Control No. 10/774,347 | Applicant(s)/Patent Under Reexamination SAWAMOTO ET AL. | |
| | Examiner Ida M. Soward | Art Unit 2822 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| | A | US-6,229,215 | 05-2001 | Egawa, Yoshimi | 257/777 |
| | B | US-2003/0127719 | 07-2003 | Chang, Charge | 257/685 |
| | C | US-6,710,455 | 03-2004 | Goller et al. | 257/777 |
| | D | US-2002/0163075 | 11-2002 | Ho et al. | 257/712 |
| | E | US-6,600,221 | 07-2003 | Kimura, Naoto | 257/686 |
| | F | US-2001/0026013 | 10-2001 | Mess et al. | 257/686 |
| | G | US-2002/0096753 | 07-2002 | Tu et al. | 257/680 |
| | H | US-6,590,281 | 07-2003 | Wu et al. | 257/684 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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